Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,639	CHEN ET AL.	
Examiner	Art Unit	-
Helen L. Pezzuto	1713	

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SEARCHED					
Class	Subclass	Date	Examiner		
526	307.3				
	307.4				
	318.2	2/2/2006	HP		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
526	307.3			
	307.4			
	318.2	2/2/2006	HP	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC STN search	1/31/2006	НР		
West, e-Dan/Palm inventors search	2/2/2006	HP		